

Notice of References Cited

Application/Control No.

10/036,421

Applicant(s)/Patent Under

Reexamination

OKADA ET AL.

Examiner

Drew E Becker

Art Unit

1761

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,077,558 A	06-2000	Euber, John	426/601
	B	US-5,972,367 A	10-1999	Inoue et al.	424/423
	C	US-3,900,573	08-1975	Freck et al.	426/274
	D	US-3,950,547	04-1976	Lamar et al.	426/74
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000-125760A	05-2000	Japan	Katayama (translated)	
	O	JP 57-21969	05-1982	Japan	Inkral (translated)	
	P	JP 63-126470	05-1988	Japan	Inoue et al (translated)	
	Q	JP 59-23777	06-1984	Japan	Hayashi (translated)	
	R	JP 59-162853	09-1984	Japan	Ito et al (translated)	
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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